WHAT IS CLAIMED IS:

5

- A method of calibrating, comprising:
 detecting a conductive area;
 detecting a reflective area; and
 determining a position based on said steps of detecting.
 - 2. The method of claim 1, wherein the position comprises three coordinates.
 - 3. The method of claim 1, wherein the step of detecting a conductive area is performed by an electrical sensor of a gripper device.
- 4. The method of claim 1, wherein the step of detecting a reflective area is performed by an optical sensor of a sample arm.
 - 5. The method of claim 4, wherein the sample arm includes a gripper device having fingers, and wherein the optical sensor projects a light beam between the fingers.
 - 6. The method of claim 1, wherein the reflective area is located on a circular member, the circular member comprising one of a sample tray and a rotating table.
- The method of claim 1, wherein the conductive area is located on a circular member, the circular member comprising one of a sample tray and a rotating table.
 - 8. The method of claim 6, wherein the circular member is a rotating table, and wherein the rotating table is coupled to a sample tray.
- 9. The method of claim 7, wherein the circular member is a rotating table, and wherein the rotating table is coupled to a sample tray.
 - 10. The method of claim 6, wherein the position is the location of a well on the sample tray.

- 11. The method of claim 7, wherein the position is the location of a well on the sample tray.
- 12. The method of claim 1, wherein the reflective area is located on a cell.
- 13. The method of claim 1, wherein the reflective area is located on a calibration
- 5 fixture coupled to a cell.
 - 14. The method of claim 1, wherein the conductive area is located on a cell.
 - 15. The method of claim 1, wherein the conductive area is located on a calibration fixture coupled to a cell.